

# Super J MOS<sup>®</sup> S2 series

## N-Channel enhancement mode power MOSFET

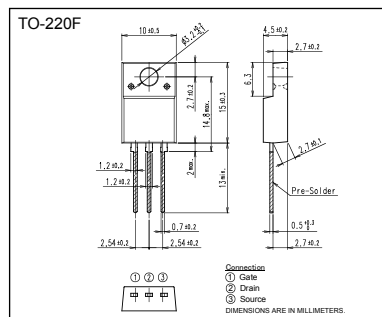
## ■ Features

Pb-free lead terminal  
RoHS compliant  
uses Halogen-free molding compound

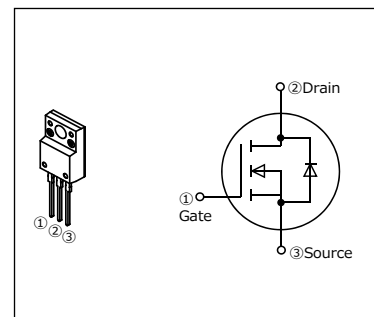
## ■ Applications

For switching

## ■ Outline Drawings [mm]



### ■ Equivalent circuit schematic



**■ Absolute Maximum Ratings at  $T_{vj}=25^{\circ}\text{C}$  (unless otherwise specified)**

| Parameter                                | Symbol         | Characteristics | Unit        | Remarks                        |
|------------------------------------------|----------------|-----------------|-------------|--------------------------------|
| Drain-Source Voltage                     | $V_{DS}$       | 600             | V           |                                |
|                                          | $V_{DSX}$      | 600             | V           | $V_{GS}=-30V$                  |
| Continuous Drain Current                 | $I_D$          | 53.2            | A           | $T_{vj}=25^{\circ}C$ Note*1,2  |
|                                          |                | 33.6            | A           | $T_{vj}=100^{\circ}C$ Note*1,2 |
| Pulsed Drain Current                     | $I_{DP}$       | 158             | A           | Note *2                        |
| Gate-Source Voltage                      | $V_{GS}$       | $\pm 30$        | V           |                                |
| Non-Repetitive Maximum Avalanche Current | $I_{AS}$       | 6.3             | A           | Note *3                        |
| Non-Repetitive Maximum Avalanche Energy  | $E_{AS}$       | 1305            | mJ          | Note *4                        |
| Maximum Drain-Source dV/dt               | d $V_{DS}$ /dt | 50              | V/ns        | $V_{DS} \leq 600V$             |
| Continuous Diode Forward Current         | $I_{SD}$       | 53.2            | A           | $T_{vj}=25^{\circ}C$ Note*1,2  |
|                                          |                | 33.6            | A           | $T_{vj}=100^{\circ}C$ Note*1,2 |
| Pulsed Diode Forward Current             | $I_{SDP}$      | 158             | A           | Note *2                        |
| Peak Diode Recovery dV/dt                | dV/dt          | 30              | V/ns        | Note *5                        |
| Peak Diode Recovery -di/dt               | -di/dt         | 100             | A/ $\mu s$  | Note *6                        |
| Maximum Power Dissipation                | $P_D$          | 2.16            | W           | $T_a=25^{\circ}C$              |
|                                          |                | 110             |             | $T_{vj}=25^{\circ}C$           |
| Operating and Storage Temperature range  | $T_{ch}$       | 150             | $^{\circ}C$ |                                |
|                                          | $T_{stg}$      | -55 to +150     | $^{\circ}C$ |                                |
| Isolation Voltage (TO-220F)              | $V_{iso}$      | 2               | kVrms       | t=60sec,f=60Hz                 |

Note \*1 : Maximum duty cycle  $D=0.55$

Note \*2 : Limited by maximum channel temperature.

Note \*3 :  $T_{ch} \leq 150^{\circ}\text{C}$ , See Fig.1 and Fig.2

Note \*4 : Starting  $T_{ch}=25^{\circ}\text{C}$ ,  $I_{AS}=3.8\text{A}$ ,  $L=166\text{mH}$ ,  $V_{DD}=60\text{V}$ ,  $R_G=50\Omega$ , See Fig.1 and Fig.2

*E*<sub>AS</sub> limited by maximum channel temperature and avalanche current.

Note \*5 :  $I_{SD} \leq 39.4A$ ,  $-di/dt \leq 100A/\mu s$ ,  $V_{DS\ peak} \leq 600V$ ,  $T_{ch} \leq 150^{\circ}C$ .

Note \*6: /sp≤39.4A, dV/dt≤30V/ns, V<sub>DS peak</sub>≤600V, T<sub>ch</sub>≤150°C.

■ Electrical Characteristics at  $T_{vj}=25^{\circ}\text{C}$  (unless otherwise specified)

## • Static Ratings

| Parameter                        | Symbol       | Conditions                                                   | Min. | Typ.  | Max.  | Unit     |
|----------------------------------|--------------|--------------------------------------------------------------|------|-------|-------|----------|
| Drain-Source Breakdown Voltage   | $BV_{DSS}$   | $V_{GS}=0V$<br>$I_D=250\mu A$                                | 600  | -     | -     | V        |
| Gate Threshold Voltage           | $V_{GS(th)}$ | $V_{DS}=V_{GS}$<br>$I_D=6.4mA$                               | 3.0  | 4.0   | 5.0   | V        |
| Zero Gate Voltage Drain Current  | $I_{DSS}$    | $V_{DS}=600V$<br>$V_{GS}=0V$<br>$T_{ch}=25^{\circ}\text{C}$  | -    | -     | 25    | $\mu A$  |
|                                  |              | $V_{DS}=480V$<br>$V_{GS}=0V$<br>$T_{ch}=125^{\circ}\text{C}$ | -    | 60    | -     |          |
| Gate-Source Leakage Current      | $I_{GSS}$    | $V_{DS}=0V$<br>$V_{GS}=\pm 30V$                              | -    | 10    | 100   | nA       |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS}=10V$<br>$I_D=19.7A$                                  | -    | 0.065 | 0.075 | $\Omega$ |
| Gate resistance                  | $R_G$        | f=1MHz, open drain                                           | -    | 6.9   | -     | $\Omega$ |

## • Dynamic Ratings

| Parameter                                              | Symbol       | Conditions                                                    | Min. | Typ. | Max. | Unit |
|--------------------------------------------------------|--------------|---------------------------------------------------------------|------|------|------|------|
| Forward Transconductance                               | $g_{fs}$     | $V_{DS}=25V$<br>$I_D=19.7A$                                   | 13.5 | 27   | -    | S    |
| Input Capacitance                                      | $C_{iss}$    | $V_{DS}=400V$                                                 | -    | 2220 | -    | $pF$ |
| Output Capacitance                                     | $C_{oss}$    | $V_{GS}=0V$                                                   | -    | 76   | -    |      |
| Reverse Transfer Capacitance                           | $C_{rss}$    | f=250kHz                                                      | -    | 9.3  | -    |      |
| Effective output capacitance, energy related (Note *7) | $C_{o(er)}$  | $V_{DS}=0\ldots 400V$<br>$V_{GS}=0V$                          | -    | 173  | -    | $pF$ |
| Effective output capacitance, time related (Note *8)   | $C_{o(tr)}$  | $V_{DS}=0\ldots 400V$<br>$V_{GS}=0V$<br>$I_D=\text{constant}$ | -    | 722  | -    |      |
| Turn-On Time                                           | $t_{d(on)}$  | $V_{DD}=400V, V_{GS}=10V$<br>$I_D=19.7A, R_G=12\Omega$        | -    | 35   | -    | ns   |
|                                                        | $t_r$        |                                                               | -    | 129  | -    |      |
| Turn-Off Time                                          | $t_{d(off)}$ | See Fig.3 and Fig.4                                           | -    | 172  | -    |      |
|                                                        | $t_f$        |                                                               | -    | 27   | -    |      |
| Total Gate Charge                                      | $Q_G$        | $V_{DD}=400V, V_{GS}=10V$<br>$I_D=39.4A$<br>See Fig.5         | -    | 97   | -    | nC   |
| Gate-Source Charge                                     | $Q_{GS}$     |                                                               | -    | 38   | -    |      |
| Gate-Drain Charge                                      | $Q_{GD}$     |                                                               | -    | 47   | -    |      |
| Drain-Source crossover Charge                          | $Q_{SW}$     |                                                               | -    | 26   | -    |      |

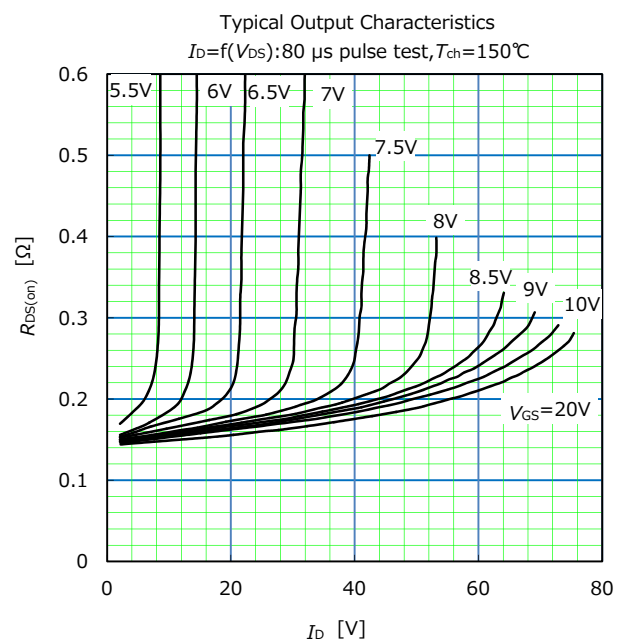
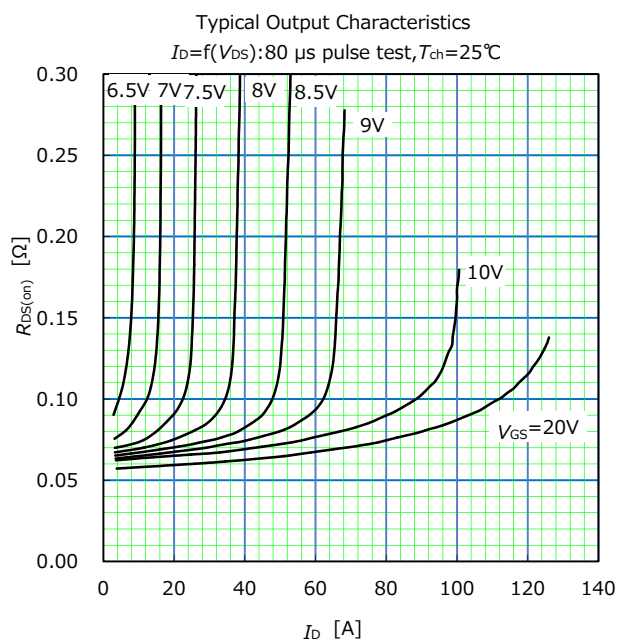
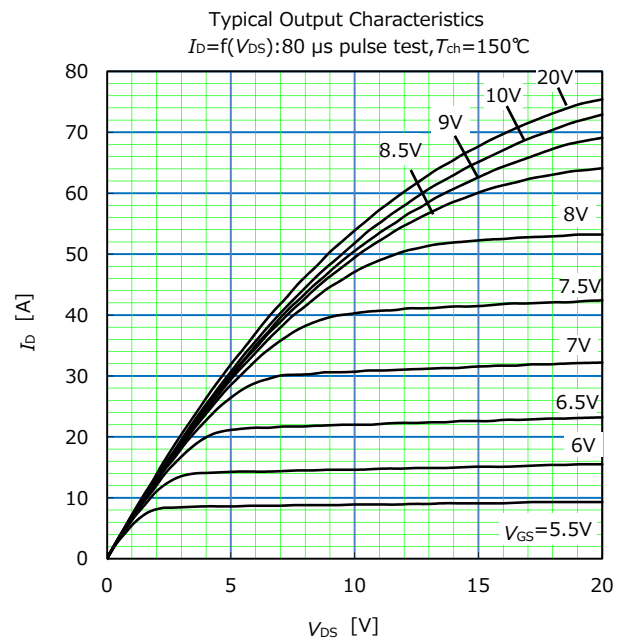
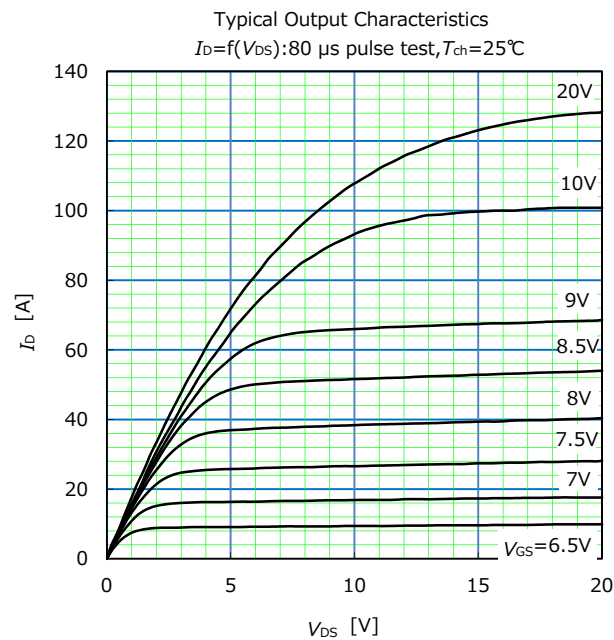
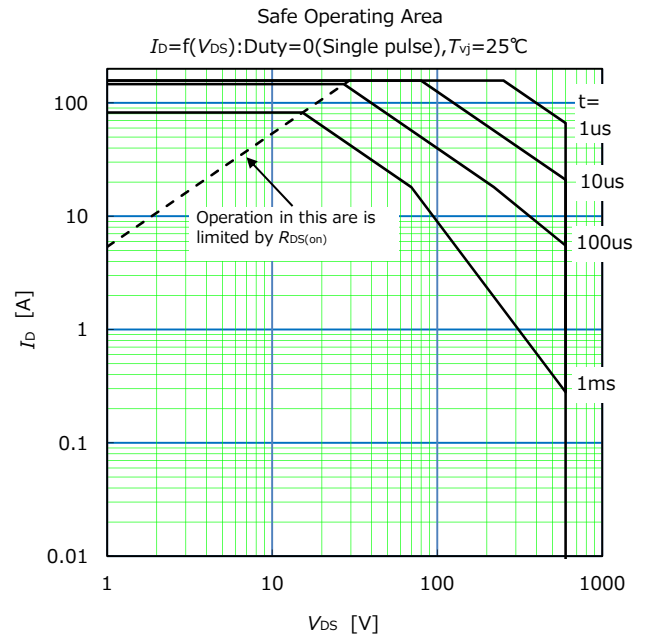
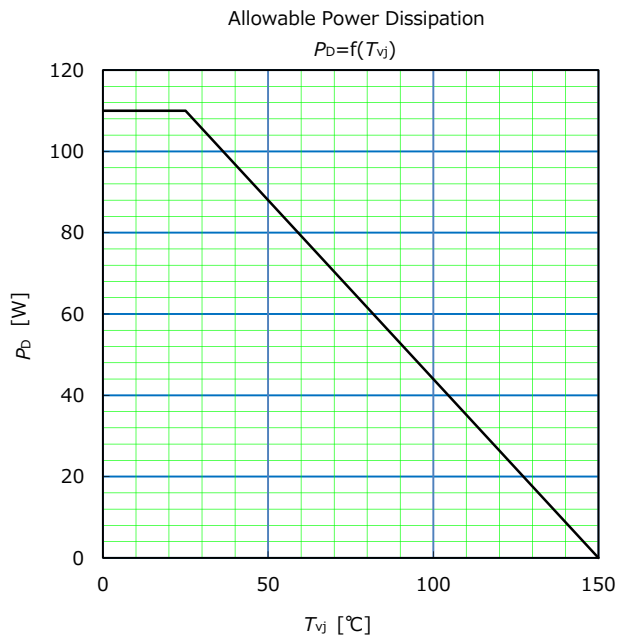
Note \*7 :  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V.Note \*8 :  $C_{o(tr)}$  is a fixed capacitance that gives the same charging times as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V.

## • Reverse Diode

| Parameter                     | Symbol   | Conditions                                                                                                | Min. | Typ. | Max. | Unit    |
|-------------------------------|----------|-----------------------------------------------------------------------------------------------------------|------|------|------|---------|
| Diode Forward On-Voltage      | $V_{SD}$ | $I_{SD}=39.4A, V_{GS}=0V$<br>$T_{ch}=25^{\circ}\text{C}$                                                  | -    | 0.95 | 1.35 | V       |
| Reverse Recovery Time         | $t_{rr}$ | $V_{DD}=400V, I_{SD}=39.4A$<br>-di/dt=100A/ $\mu s$<br>$T_{ch}=25^{\circ}\text{C}$<br>See Fig.6 and Fig.7 | -    | 207  | -    | ns      |
| Reverse Recovery Charge       | $Q_{rr}$ |                                                                                                           | -    | 2.0  | -    | $\mu C$ |
| Peak Reverse Recovery Current | $I_{rp}$ |                                                                                                           | -    | 18.4 | -    | A       |

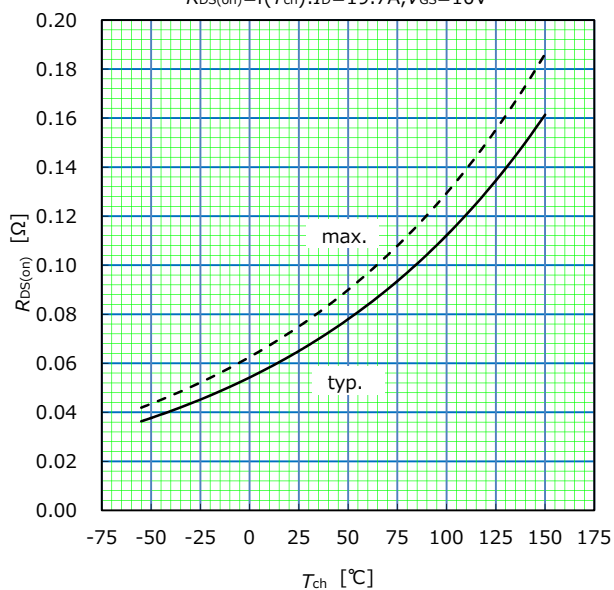
## ■ Thermal Resistance

| Parameter          | Symbol         | Min. | Typ. | Max. | Unit                 |
|--------------------|----------------|------|------|------|----------------------|
| Channel to Case    | $R_{th(ch-c)}$ | -    | -    | 1.14 | $^{\circ}\text{C/W}$ |
| Channel to Ambient | $R_{th(ch-a)}$ | -    | -    | 58   | $^{\circ}\text{C/W}$ |



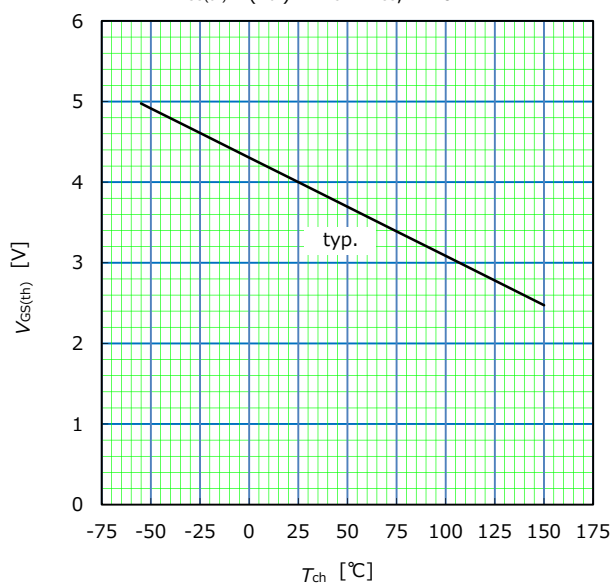
Drain-Source On-state Resistance

$$R_{DS(on)} = f(T_{ch}) : I_D = 19.7A, V_{GS} = 10V$$



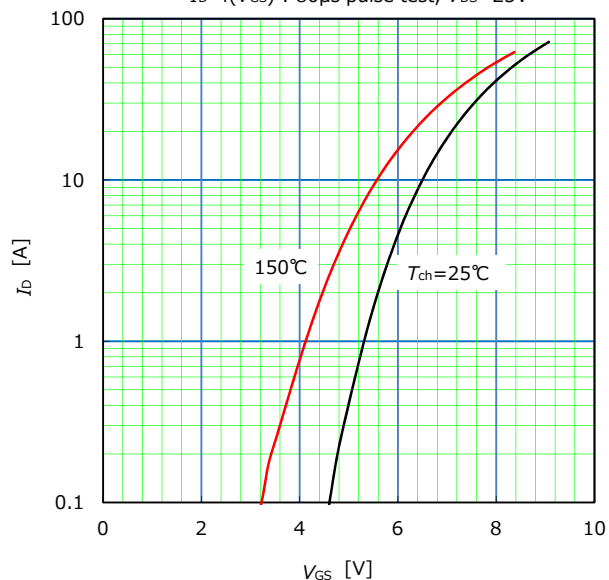
Gate Threshold Voltage vs.  $T_{ch}$

$$V_{GS(th)} = f(T_{ch}) : V_{DS} = V_{GS}, I_D = 6.4mA$$



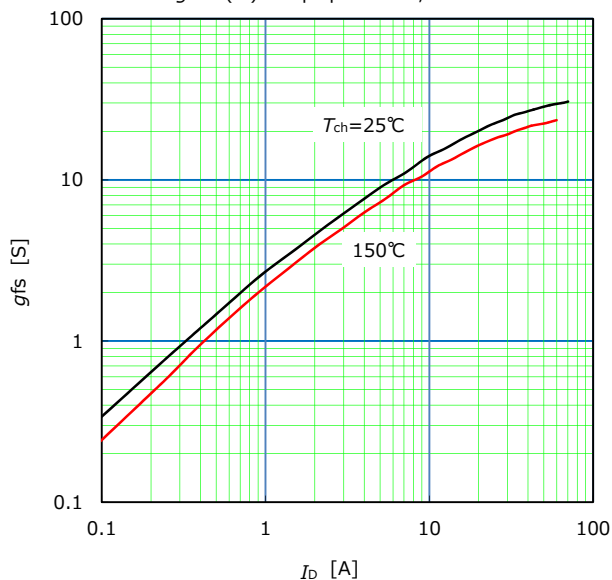
Typical Transfer Characteristic

$$I_D = f(V_{GS}) : 80\mu s \text{ pulse test, } V_{DS} = 25V$$



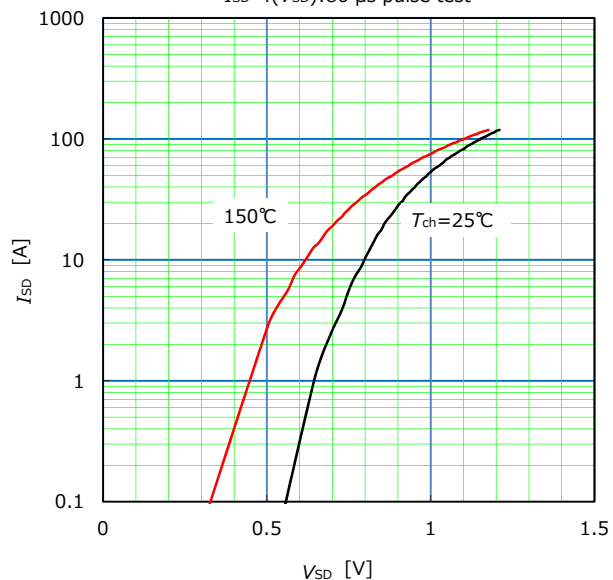
Typical Transconductance

$$g_{fs} = f(I_D) : 80\mu s \text{ pulse test, } V_{DS} = 25V$$



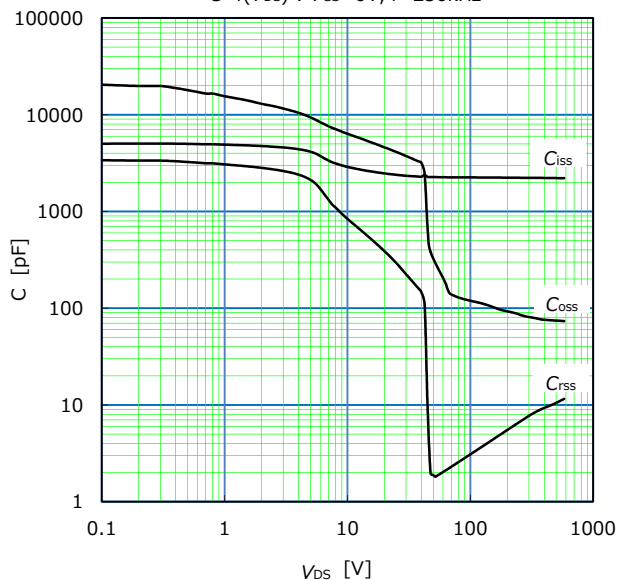
Typical Forward Characteristics of Reverse Diode

$$I_{SD} = f(V_{SD}) : 80\mu s \text{ pulse test}$$

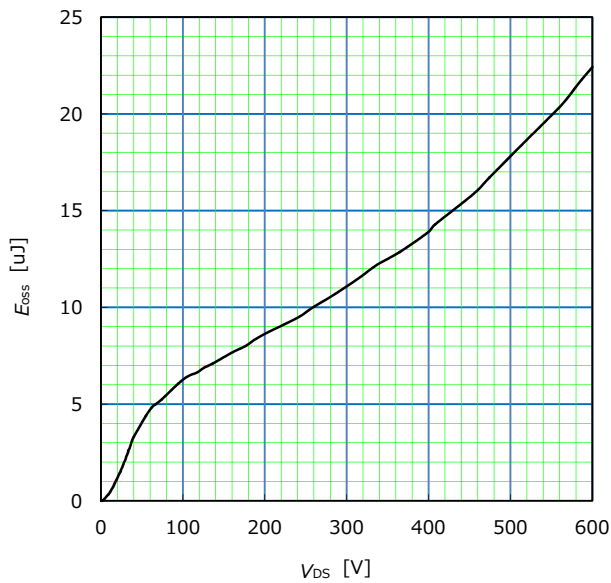


Typical Capacitance

$$C = f(V_{DS}) : V_{GS} = 0V, f = 250kHz$$

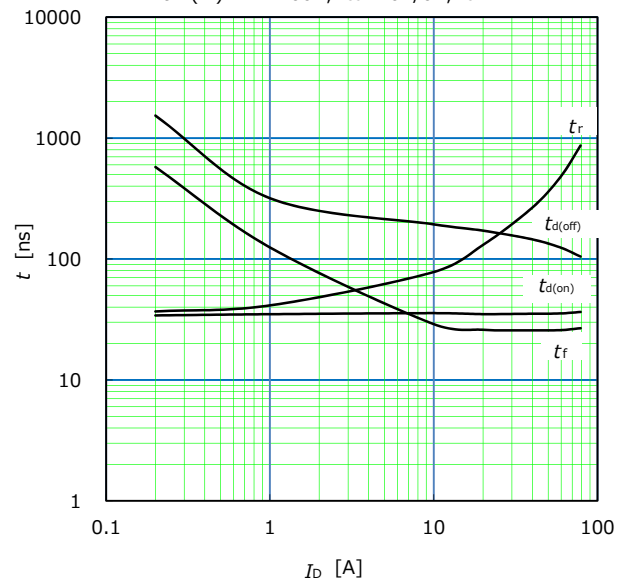


Typical  $C_{oss}$  stored energy



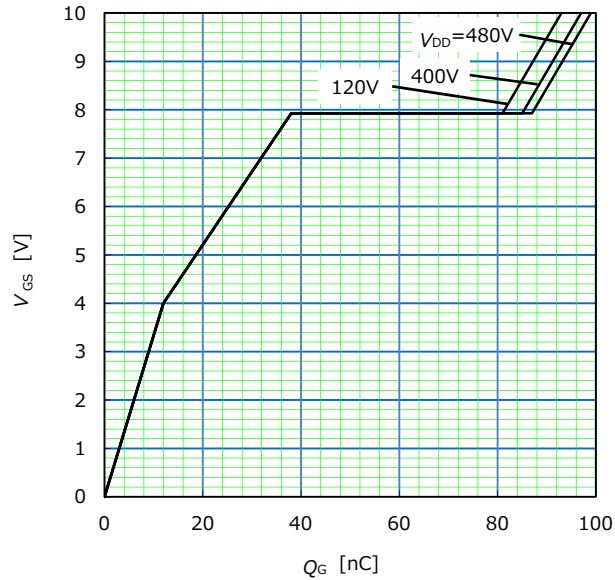
Typical Switching Characteristics vs.  $I_D$   $T_{ch}=25^\circ\text{C}$

$t=f(I_D): V_{DD}=400\text{V}, V_{GS}=10\text{V}/0\text{V}, R_G=12\Omega$



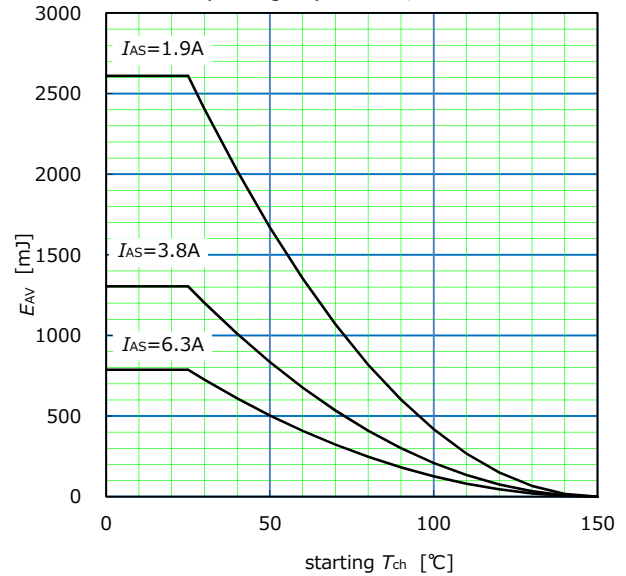
Typical Gate Charge Characteristics

$V_{GS}=f(Q_G): I_D=39.4\text{A}, T_{ch}=25^\circ\text{C}$



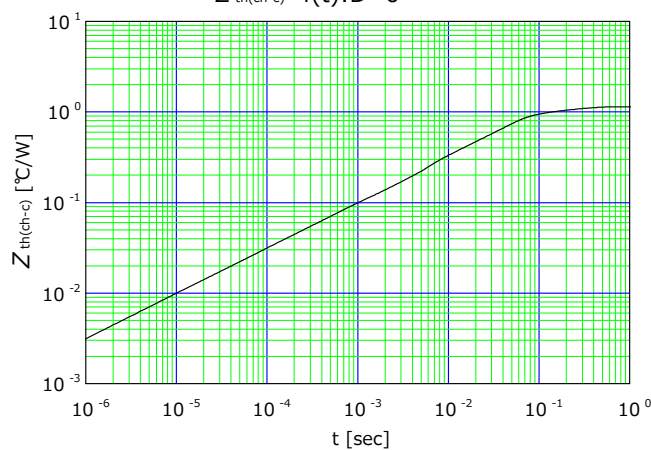
Maximum Avalanche Energy vs. starting  $T_{ch}$

$E_{(AV)}=f(\text{starting } T_{ch}): V_{CC}=60\text{V}, I_{(AV)} \leq 6.3\text{A}$



Transient Thermal Impedance

$Z_{th(ch-c)}=f(t): D=0$



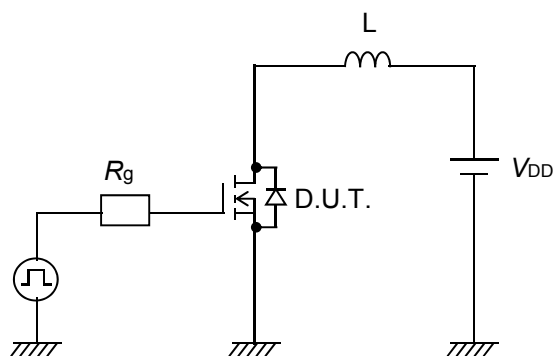


Fig.1 Avalanche Test circuit

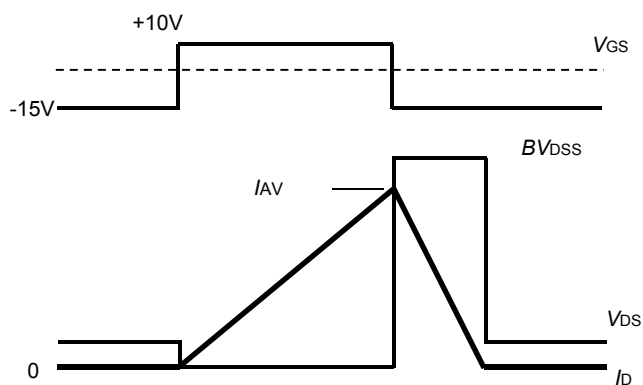


Fig.2 Operating waveforms of Avalanche Test

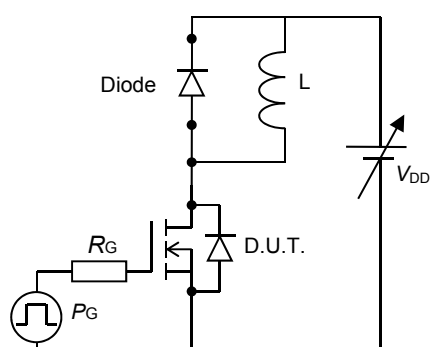


Fig.3 Switching Test circuit

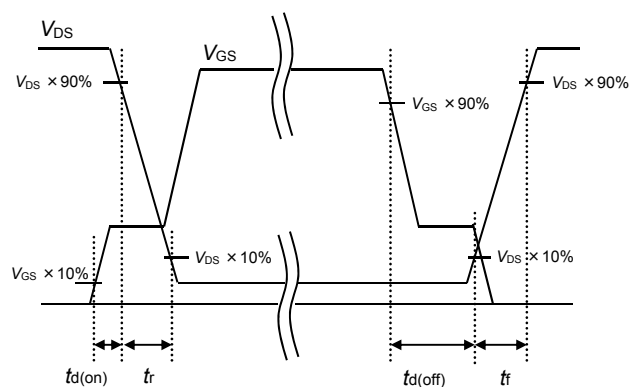


Fig.4 Operating waveform of Switching Test

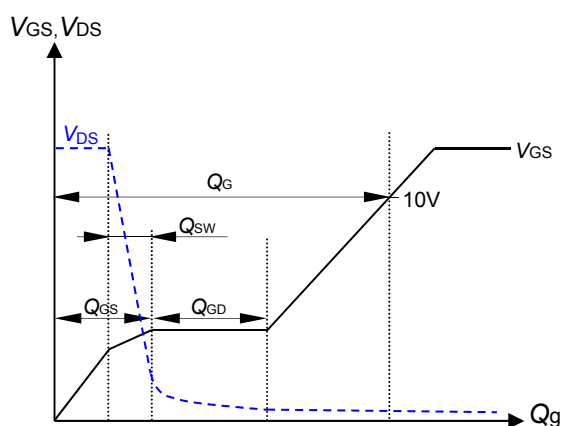


Fig.5 Operating waveform of Gate charge Test

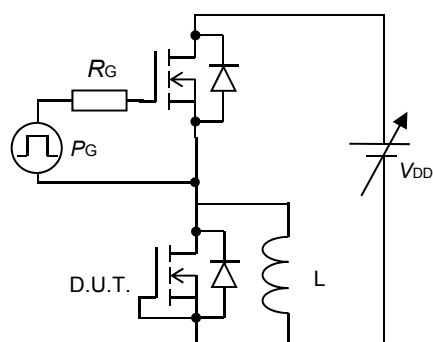


Fig.6 Reverse recovery Test circuit

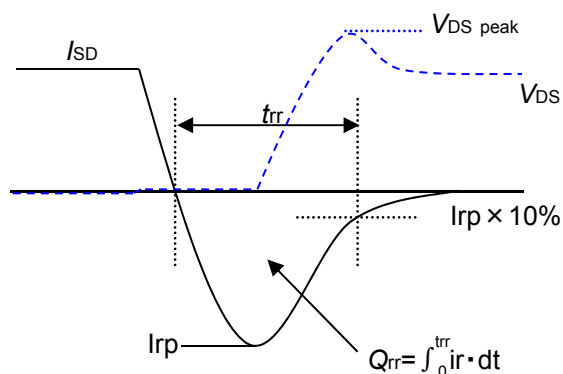
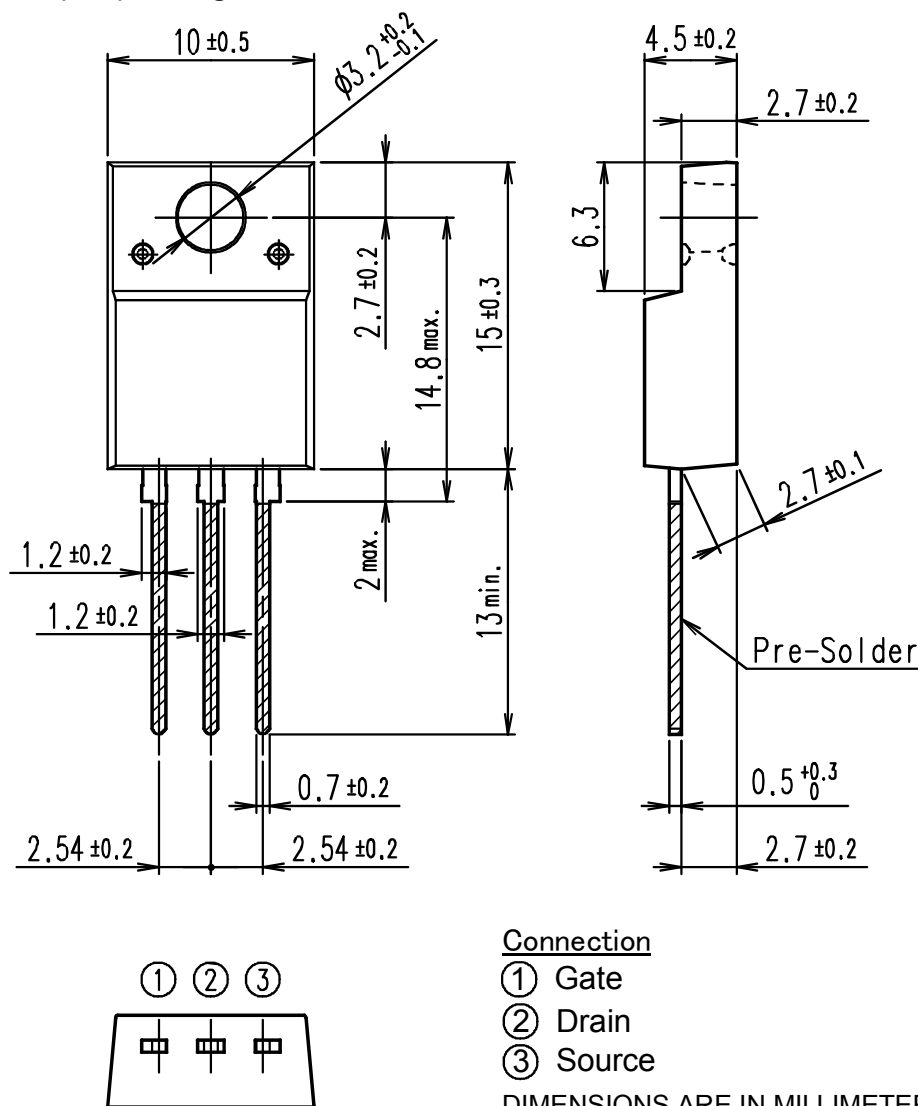


Fig.7 Operating waveform of Reverse recovery Test

■ Outview: TO-220F(SLS) Package

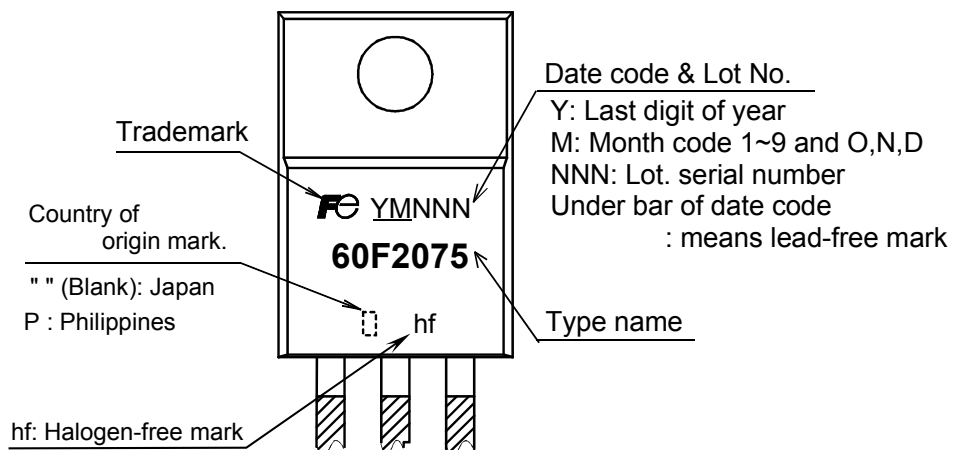


Connection

- ① Gate
- ② Drain
- ③ Source

DIMENSIONS ARE IN MILLIMETERS.

■ Marking



\* The font (font type,size) and the trademark-size might be actually different.

**WARNING**

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|                 |                         |                                               |                          |
|-----------------|-------------------------|-----------------------------------------------|--------------------------|
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| • Machine tools | • Audiovisual equipment | • Electrical home appliances                  | • Personal equipment     |
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|                                                                             |                                                       |
|-----------------------------------------------------------------------------|-------------------------------------------------------|
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| • Traffic-signal control equipment                                          | • Gas leakage detectors with an auto-shut-off feature |
| • Emergency equipment for responding to disasters and anti-burglary devices | • Safety devices                                      |
| • Medical equipment                                                         |                                                       |
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|                                |                        |                             |
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| • Submarine repeater equipment |                        |                             |
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